JJMICROELECTRONICS

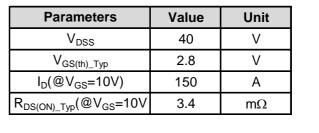
40V, 150A, 3.4mΩ N-channel Power Trench MOSFET JMTC035N04A

Features

- Excellent $\mathsf{R}_{\mathsf{DS}(\mathsf{ON})}$ and Low Gate Charge
- 100% UIS Tested
- 100% ΔVds Tested
- Halogen-free; RoHS-compliant

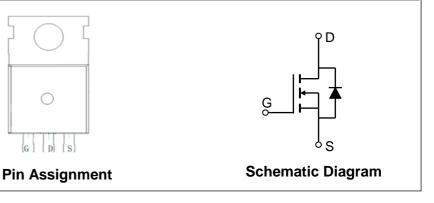
Applications

- Load Switch
- PWM Application
- Power Management





Product Summary



Ordering Information

TO-220-3L Top View

Device	Marking	MSL	Form	Package	Tube(pcs)	Per Carton (pcs)
JMTC035N04A	JMTC035N04A	N/A	Tube	TO-220-3L	50	5000

Absolute Maximum Ratings (@ $T_C = 25^{\circ}C$ unless otherwise specified)

Symbol	Parameter		Value	Unit
V _{DS}	Drain-to-Source Voltage	Drain-to-Source Voltage		V
V _{GS}			±20	V
	Continuous Droin Current		150	А
Ι _D	Continuous Drain Current	$T_{\rm C} = 100^{\circ}{\rm C}$	106	~
I _{DM}	Pulsed Drain Current ⁽¹⁾	Pulsed Drain Current ⁽¹⁾		А
E _{AS}	Single Pulsed Avalanche Energy	Single Pulsed Avalanche Energy ⁽²⁾		mJ
P _D	Dower Dissinction	$T_{\rm C} = 25^{\circ}{\rm C}$	216	w
		$T_{\rm C} = 100^{\circ}{\rm C}$	87	vv
T _J , T _{STG}	Junction & Storage Temperature R	Junction & Storage Temperature Range		°C

Thermal Characteristics

Symbol	Parameter	Мах	Unit
R_{\thetaJA}	Thermal Resistance, Junction to Ambient ⁽³⁾	75	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case 0.6		C/VV

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Cha	aracteristics			1		<u>.</u>
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$I_{D} = 250 \mu A, V_{GS} = 0 V$	40	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 40V, V_{GS} = 0V$	-	-	1.0	μA
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Cha	racteristics					-
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2.0	2.8	4.0	V
R _{DS(ON)}	Static Drain-Source ON-Resistance ⁽⁴⁾	$V_{GS} = 10V, I_D = 30A$	-	3.4	4.0	mΩ
Dynami	ic Characteristics					
R_g	Gate Resistance	f = 1MHz	-	1.7	-	Ω
C _{iss}	Input Capacitance		3517	4924	6647	pF
C _{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 20V,$ f = 1MHz	361	505	682	pF
C _{rss}	Reverse Transfer Capacitance		194	272	367	pF
Qg	Total Gate Charge		52	73	99	nC
Q _{gs}	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 20V, I_D = 30A$	20	27	37	nC
Q_{gd}	Gate Drain("Miller") Charge	VDS = 200, 10 = 00, 1	10	15	20	nC
Switchi	ing Characteristics					
t _{d(on)}	Turn-On DelayTime		-	17	-	ns
t _r	Turn-On Rise Time	$V_{GS} = 10V, V_{DD} = 20V$	-	27	-	ns
t _{d(off)}	Turn-Off DelayTime	$I_D = 30A, R_{GEN} = 3\Omega$	-	39	-	ns
t _f	Turn-Off Fall Time		-	11	-	ns
Body D	iode Characteristics	•		•	•	•
I _S	Maximum Continuous Body Diode Forward	Current	-	-	150	А
I _{SM}	Maximum Pulsed Body Diode Forward Current		-	-	600	А
V_{SD}	Body Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 30A$	-		1.2	V
trr	Body Diode Reverse Recovery Time		18	25	33	ns
Qrr	Body Diode Reverse Recovery Charge	− I _F = 30A, di/dt = 100A/us	-	17	-	nC

Electrical Characteristics ($T_J = 25^{\circ}C$ unless otherwise specified)

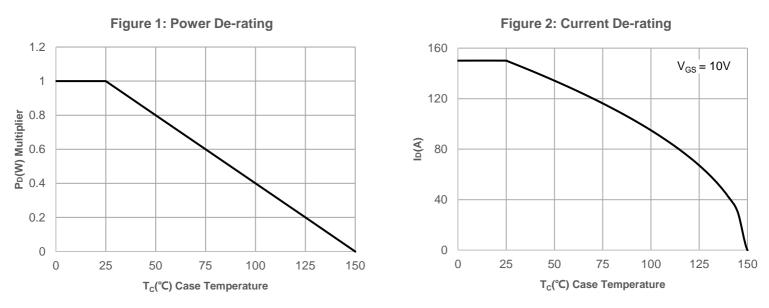
Notes: 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

2. E_{AS} condition: Starting T_J =25C, V_{DD} =20V, V_G =10V, R_G =25ohm, L=0.5mH, I_{AS} =35.7A, V_{DD} =0V during time in avalanche.

3. $R_{\theta JA}$ is measured with the device mounted on a 1inch 2 pad of 2oz copper FR4 PCB.

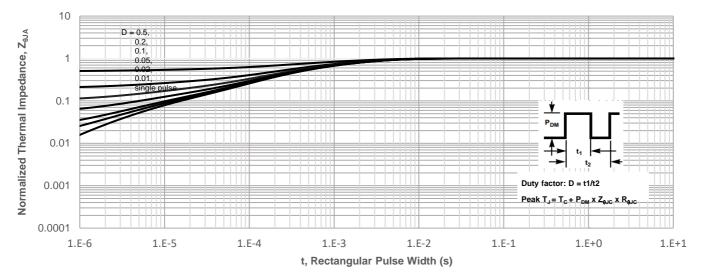
4. Pulse Test: Pulse Width ${\leqslant}300\mu\text{s},$ Duty Cycle ${\leqslant}0.5\%.$



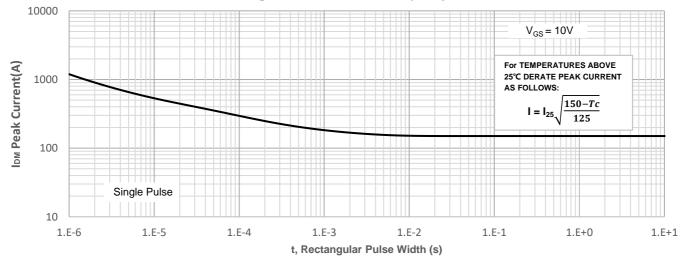


Typical Performance Characteristics







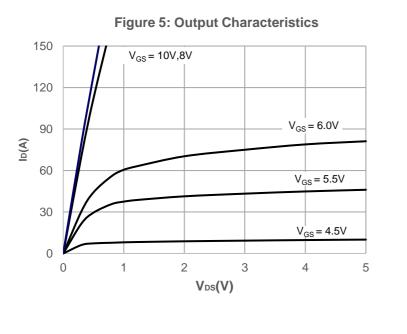




T_J= -55°C

1

1.2



Typical Performance Characteristics

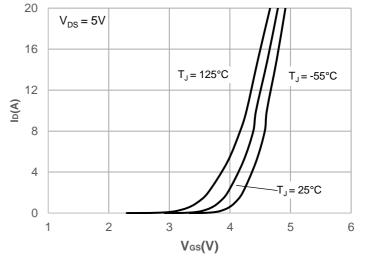


Figure 8: Body Diode Characteristics

_= 25°C

100

10

1

0.1

0.01

0

0.2

Is(A)

 $V_{GS} = 0V$

T_J = 125°C

0.4

Figure 6: Typical Transfer Characteristics

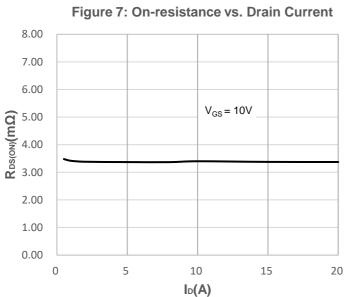
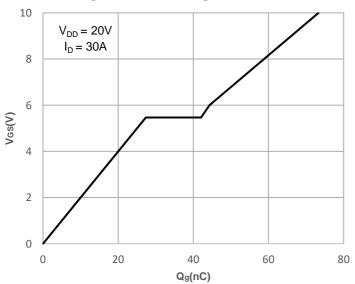


Figure 9: Gate Charge Characteristics

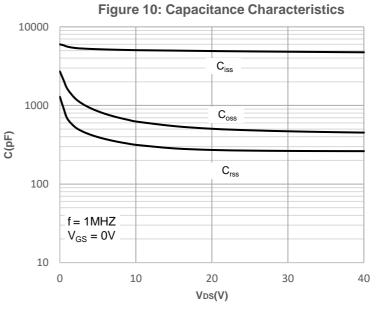


auro 10. Consoltanos Characteristico

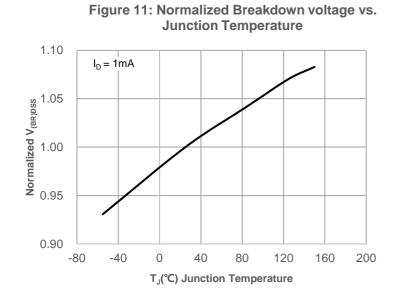
0.8

0.6

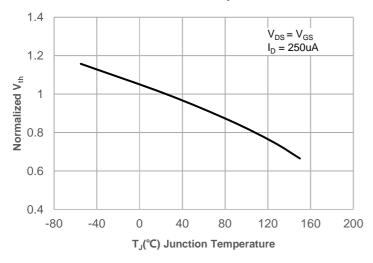
Vsd(V)

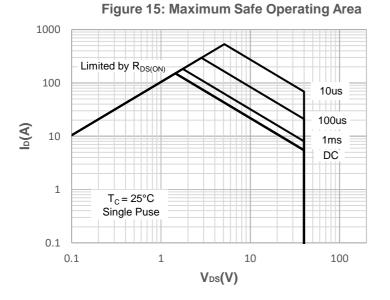




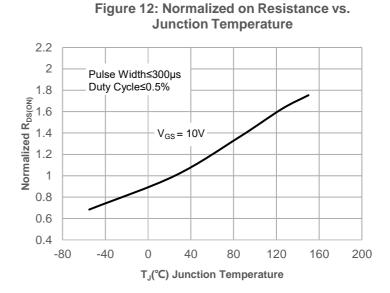


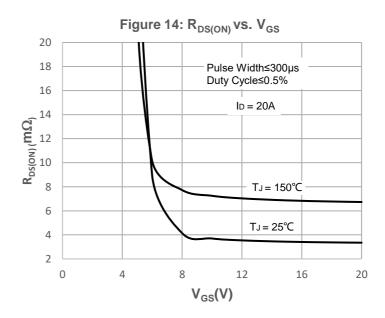














Test Circuit

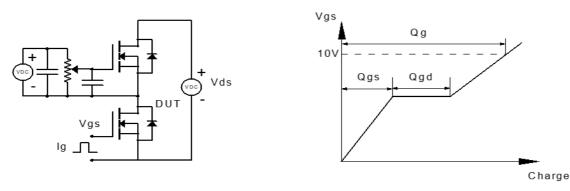


Figure 1: Gate Charge Test Circuit & Waveform

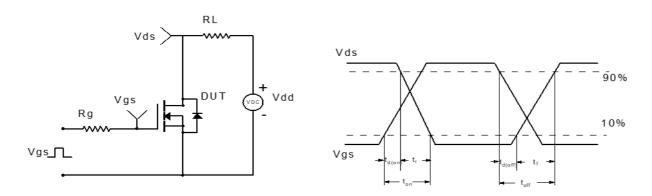


Figure 2: Resistive Switching Test Circuit & Waveform

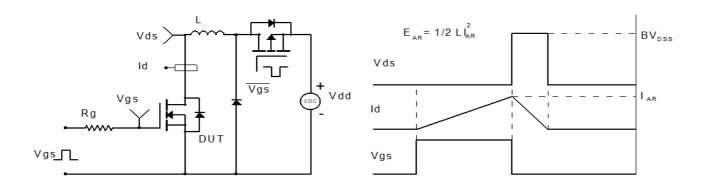


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

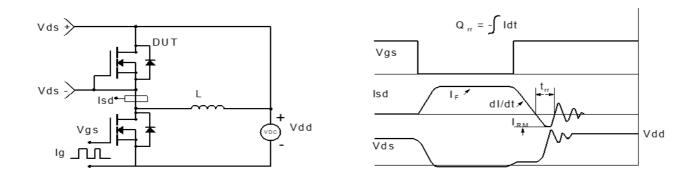
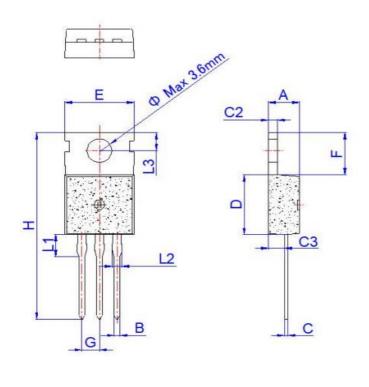


Figure 4: Diode Recovery Test Circuit & Waveform



Package Mechanical Data(TO-220-3L)



Ref.			Dime	ensions			
	Millimeters			Inches			
	Min.	Тур.	Max.	Min.	Тур.	Max.	
A	4.40		4.60	0.173		0.181	
В	0.70		0.90	0.028		0.035	
С	0.45		0.60	0.018		0.024	
C2	1.23		1.32	0.048		0.052	
C3	2.20		2.60	0.087		0.102	
D	8.90		9.90	0.350		0.390	
E	9.90		10.3	0.390		0.406	
F	6.30		6.90	0.248		0.272	
G		2.54			0.1		
Н	28.0		29.8	1.102		1.173	
L1		3.39			0.133		
L2	1.14		1.70	0.045		0.067	
L3	2.65		2.95	0.104		0.116	
Φ		3.6			0.142		

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